

Posterior consistency:

$$D^n \sim p_n(d^n | \theta), \theta \in \Theta, \theta \sim \Pi_n$$

$$\Pi_n(B | D^n) = \frac{\int_B p_n(D^n | \theta) d\Pi_n(\theta)}{\int_{\Theta} p_n(D^n | \theta) d\Pi_n(\theta)}, B \subset \Theta$$

$$p_n(d^n | \theta) = \prod_{i=1}^n f(x_i | \theta)$$

Expect:  $\Pi_n(\cdot | D^n) \xrightarrow{\text{weakly}} \delta_{\theta_0}$ .

$$g_n(\theta) := d_w(\Pi_n(\cdot | D^n), \delta_{\theta_0})$$

$d_w$  = wasserstein metric

Def. 1: The posterior sequence is consistent at  $\theta_0$  if  $g_n(\theta_0) \rightarrow 0$  a.s. or in prob. when

$$D^n \sim p_n(\cdot | \theta_0)$$

Lemma 1: If  $(\theta, d)$  is separable,  
 $g_n(\theta_0) \rightarrow 0$  a.s. or i.p. iff

$\forall$  open neighborhood  $U$  of  $\theta_0$

$$\Pi_n(U^c | D^n) \rightarrow 0 \text{ a.s. / i.p.}$$

The Schwartz theorem:

$$D^n = (X_1, \dots, X_n); X_i \stackrel{\text{iid}}{\sim} f, f \in \mathcal{F}$$

$$d_{KL}(p, q) = \int p(x) \log \left( \frac{p(x)}{q(x)} \right) dx$$

Test fcn:  $\bar{I}_n : \mathcal{X}^n \rightarrow [0, 1]$ .

$f = f_0$  is true density.  $P_0^\infty$  joint density of  $(X_1, \dots, X_n)$ .  $f_0$  belongs to the KL support of  $\pi$  if

$$\forall \varepsilon > 0, \text{TT}(f : d_{KL}(f_0, f) < \varepsilon) > 0.$$

Theorem: If  $f_0$  belongs to the KL support of  $\pi$  &  $U_n \subset \mathcal{F}$  are neighborhoods of  $f_0$  s.t.  $\bar{I}_n$  with

$$E_{f_0} \bar{I}_n \leq B e^{-bn} \quad \text{Type I error}$$

$$\sup_{f \in U_n^c} E_f (1 - \bar{I}_n) \leq B e^{-bn} \quad \text{Type II error}$$

for  $b, B > 0$  then  $\text{TT}(U_n^c | P_n) \rightarrow 0$

a.s.  $P_0^\infty$ ;

## Technical extension (for infinite dim models)

A sequence of compact subsets  $\tilde{F}_n \subset \tilde{F}$  are called sieves if:

The metric  $d$  on  $\tilde{F}$  is bounded from above by  $d_h$ . Fix  $\epsilon > 0$ ,  $\tilde{F}_n \subset \tilde{F}$  and  $\delta > 0$ ,  $0 < \xi < \frac{1}{2}$ ,  $C > 0$  s.t.

$$1) \log N(\delta, \tilde{F}_n, d) \leq \xi n \epsilon^2$$

$$2) \pi(\tilde{F}_n^c) \leq e^{-Cn}.$$

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What about non-iid, dynamical systems?

There is a variational form of posterior consistency based on large deviation theory.

non-iid models:

$$\text{Markov: } X_{t+1} = f(X_t; \theta)$$

$$\text{HMM: } \begin{aligned} X_{t+1} &= f(X_t; \theta) && : \text{state} \\ Y_{t+1} &= g(X_{t+1}; \varphi) && : \text{obs. process} \end{aligned}$$

Deterministic dynamics -  $\theta \in \Theta$  we

have  $(X, \mathcal{X}, T_\theta, \mu_\theta)$

- $X$  is complete separable metric space with Borel  $\sigma$ -algebra  $\mathcal{X}$
- $T_\theta: X \rightarrow X$  is a measurable map
- $\mu_\theta$ : on  $(X, \mathcal{X})$  is  $T_\theta$ -invariant if  $\mu_\theta(T_\theta^{-1} A) = \mu_\theta(A) \quad \forall A \in \mathcal{X}$
- the system is ergodic:  $T_\theta^{-1} A = A \Rightarrow \mu(A) = \{0, 1\}$

$$(X, \mathcal{X}, T_\theta, \mu_\theta)_{\theta \in \Theta} = (T_\theta, \mu_\theta)_{\theta \in \Theta}$$

Observation process:

$$\int g_\theta(y|x) d\nu(y) = 1$$

$$g: \Theta \times X \times Y \rightarrow \mathbb{R}_+$$

$$p_\theta(y_0^n | x) = \prod_{k=0}^n g_\theta(y_k | T_\theta^k(x))$$

$$p_\theta(y_0^n) = \int p_\theta(y_0^n | x) d\mu_\theta(x)$$

$$X_0 \sim U[0,1]$$

$$x_{t+1} = \theta x_t (1-x_t)$$

$$Y_{t+1} = N(x_{t+1}, \sigma^2)$$

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Generalized Baye set-up

a) Observation system  $(Y, T, \nu)$ ,  
 $T: Y \rightarrow Y$

b) Tracking systems:  $X \in \mathcal{X} \times \mathcal{A}$ ,  
 $S: \Theta \times X \rightarrow \mathcal{X}$ ,  $s_\theta: X \rightarrow \mathcal{X}$

c) loss:  $X \times Y \rightarrow R_+$

$$\ell_n(x, y; \theta) := \ell_n(x_0^{n-1}, y_0^{n-1}) \\ = \sum_{k=0}^{n-1} \ell(x_k, y_k)$$

$$x_0^{n-1} = (x, \varsigma_\theta x, \dots, \varsigma_\theta^{n-1}(x))$$

$$y_0^{n-1} = (y, T y, \dots, T^{n-1} y)$$

Gibbs posterior -

$$\Pi_n(A|y) := \frac{\int_A \exp(-\ell_n(x, y; \theta)) d\pi(x)}{Z_n(y)}$$

$$Z_n(y) = \int_X \exp(-\ell_n(x, y; \theta)) d\pi(x)$$

(1) is  $\lim_{n \rightarrow \infty} \Pi_n(\cdot|y)$  unique

(2) does it concentrate around  $T$

$$P_n(A|y) = \frac{\int_A \exp(-\psi l_n(x, y; \theta) d\theta)}{Z_n(y)}$$

Sequence space model

$A$  is a finite set ( $|A| = N$ ),  $\Sigma = A^{\mathbb{Z}}$

Left shift :  $\sigma : A^{\mathbb{Z}} \rightarrow A^{\mathbb{Z}}$  &  $(\sigma x)_i = x_{i+1}$

$$\Sigma_u = \left\{ x \in A^{\mathbb{Z}} \mid x_{[i, j]} \neq u \quad \forall i, j \in \mathbb{Z}, \right. \\ \left. u \in F \right\}$$

forbids a finite # of words  $F$

Shift of finite type (SFT)

Note: model system to study  
systems like axiom A

Can encode  $\Sigma_u$  by a matrix  $A$ :

$$\Sigma_A = \left\{ (a_i)_{i=-\infty}^{\infty} \in \Sigma_u, A_{a_i, a_{i+1}} = 1 \quad \forall i \in \mathbb{Z} \right\}$$

a topological Markov chain or  
1-step SFT

$\Sigma_A$  is mixing iff  $\exists n \geq 1$  s.t.

$A^n$  consists of all positive entries.

Gibbs measure:

Let  $f: \Sigma_f \rightarrow \mathbb{R}$  be continuous.

A measure  $\mu$  on  $\Sigma_f$  has the Gibbs property for  $f$  if there exists  $K > 1$  and  $P \in \mathbb{R}$  s.t.  $\forall$

$x \in A^{\mathbb{Z}}$  and  $m \geq 1$

$$K^{-1} \leq \frac{\mu(x[0, m-1])}{\exp(-P_m + \sum_{k=0}^{m-1} f(\sigma^k(x)))} \leq K.$$

Theorem (Bowen):

If  $\Sigma_f$  is a mixing SFT and  $f: \Sigma_f \rightarrow \mathbb{R}$  is Hölder continuous then there exists a unique Gibbs measure on  $\Sigma_f$ .

$f: \Sigma_f \rightarrow \mathbb{R}$  is called the potential

$P = P(f)$  is its pressure.

Model class:

Let  $\Theta$  be a compact metric space.

Let  $\{f_\theta : \theta \in \Theta\}$  be a continuous parametrized family of Hölder continuous potential func's.

Let  $\{\mu_\theta : \theta \in \Theta\}$  be the corresponding family of Gibbs measures.

Markov chains are an example.

Observation process: Let  $\lambda$  be a Borel measure on  $\mathcal{Y}$

Let  $g : \Theta \times X \times \mathcal{Y} \rightarrow [0, \infty)$  be a measurable func. s.t.  $\forall \theta \in \Theta$  and  $x \in X$

$$\int g(\theta, x, y) \lambda(dy) = 1$$

$$g_\theta(\cdot | x) = g(\theta, x, \cdot)$$

Hidden Gibbs process:

$$\rho_\theta(y_{0:n}) = \int \prod_{k=0}^{n-1} g_\theta(y_k | \sigma^k(x)) \mu_\theta(dx)$$

$$x_0 \sim \mu_\theta, x_{n+1} = \sigma(x_n), y_n \sim g_\theta(y | x_n) \lambda(dy)$$

$P_\theta^Y$  denote the distribution of  
 $\{Y_n\}_{n \geq 0}$  under  $\theta$ .

For  $\Theta \subset \Theta$ , let  $[\Theta] = \{\theta' \in \Theta : P_\theta^Y = P_{\theta'}^Y\}$

Theorem: Suppose  $\pi$  is fully supported on  $\Theta$ , let  $\theta_0 \in \Theta$ . Then for any neighborhood  $V$  of  $[\theta_0]$

$$\hat{\Pi}_n(\theta \setminus V | Y_0^{n-1}) \rightarrow 0, P_{\theta_0}^Y \text{-a.s.}$$

$$\hat{\Pi}_n(A | Y_0^{n-1}) = \frac{\int_A \exp(-l(\theta, x; Y_0^{n-1})) P_0(d\tau, dx)}{Z_n(Y_0^{n-1})}$$

Questions:

1. What is

$$\lim_n \frac{1}{n} \log Z_n(Y_0^{n-1})$$

2. Convergence of  $\{\hat{\Pi}_n\}$

Coupling: A coupling of two r.v.'s  $X, X'$  taking values in  $(E, \mathcal{E})$  is any pair of r.v.'s  $(Y, Y')$  in  $(E \times E, \mathcal{E} \times \mathcal{E})$  with  $X \stackrel{D}{=} Y$ ,  $X' \stackrel{D}{=} Y'$

Joining: Let  $(X, A, \mu, T)$  and  $(Y, B, \nu, S)$  be two dynamical systems. A joining of  $S, T$  is a prob. measure  $\pi$  on  $X \times Y$  with marginals  $\mu, \nu$ , and invariant to the product map  $T \times S$ .

A stationary  $X$ -valued process  $\{X_n\}_{n \geq 0}$  is in  $\mathcal{P}(X, \sigma)$  if

$$X_{n+1} = \sigma(X_n), \quad \forall n \text{ w.p. 1.}$$

A joining of  $(X, \sigma)$  with  $\{Y_n\}_{n \geq 0}$  is a stationary bi-variate process  $(U, V) = \{(U_n, V_n)\}_{n \geq 0}$  on  $X \times Y$  s.t.

$U = \{U_n\}_{n \geq 0}$  is in  $\mathcal{P}(X, \sigma)$

$V = \{V_n\}_{n \geq 0} \stackrel{d}{=} \{Y_n\}_{n \geq 0}$

We denote the set of joinings of  $(X, \sigma)$  with  $\{Y_n\}$  as  $\mathcal{T}$

Theorem. There exists a lower semicontin fcn.  $\theta: \Theta \rightarrow \mathbb{R}$  s.t. w.p. 1

$$\lim_n -\frac{1}{n} \log \tau_n(y) = \inf_{\theta \in \Theta} \theta(\omega)$$

The r.h.s. is the rate fcn. in the large deviation sense.

Limiting average cost:

$$\lim_{n \rightarrow \infty} \frac{1}{n} \int_X \ln(x, y) d\gamma_y(x) = \int \ln d\lambda$$

Entropy : measures  $\pi, \mu$  on  $X$ , finite measurable partition  $\{\dots\}$

$$H \subset \Pi \Rightarrow H(c) = 0 \Rightarrow \mu(c) = 0 \text{ for } c \in \{\dots\}$$

$$L(u||\pi, \{\dots\}) = \begin{cases} \sum_{c \in \{\dots\}} u(c) \log \pi(c) \\ -\infty \end{cases}$$

$$F(u, \pi) = \sup_{\{\dots\}} L(u||\pi, \{\dots\})$$

Theorem: Given a Gibbs prior

$$\lim_{n \rightarrow \infty} -\frac{1}{n} \log Z_n(\gamma) = \inf_{\lambda \in \mathcal{T}} \{ \int d\lambda + F(\lambda, \mu_\theta) \}$$

recall

$$\Pi^*(\theta | x) = \arg \min_{\mu} \left\{ \int_x \ell(\theta, x) d\mu(\theta) + d_{KL}(\mu, \pi) \right\}$$

Prop.: Suppose a Gibbs prior and pressure

$$P = \inf_{\lambda \in \mathcal{T}} \{ \int d\lambda + F(\lambda, \mu_\theta) \}$$

$$\theta_* = \arg \min_{\theta \in \Theta} P$$

For all  $\varepsilon > 0$

$$P(d(s_{\theta}, T) < \varepsilon) \rightarrow 1 \text{ a.s. } n \rightarrow \infty$$

Large deviations approach:

Two conditions need to hold for post-consistency

1) Conditional large deviations for one process on  $X \times Y$

2) Prove exponential continuity over the map  $\Theta \mapsto \mu_\theta$ ; allows us to extend the CDP for one family of all of  $\Theta$ .

Given a Polish space  $\mathcal{Z}$  and a lower semicontinuous fcn.  $\mathcal{I} : \mathcal{Z} \rightarrow [0, \infty]$ .

A family  $(\nu_t)_{t \in T}$  of prob measures satisfies the large deviations principle with rate fcn  $\mathcal{I}$  if for every closed set  $E \in \mathcal{Z}$

$$\limsup_{t \rightarrow \infty} \frac{1}{t} \log \nu_t(E) \leq \inf_{z \in E} \mathcal{I}(z)$$

and open set  $V \subset \mathcal{Z}$

$$\liminf_{t \rightarrow \infty} \frac{1}{t} \log \nu_t(V) \geq -\inf_{z \in V} \mathcal{I}(z)$$

Step 4: For a fixed  $\theta$  show

$$\lim_{t \rightarrow \infty} \frac{1}{t} \log Z_t^\theta(\gamma) = \inf_{\lambda \in J(s; \nu)} \left\{ \int l d\lambda + F(\lambda, \pi) \right\}$$

$$= -V(\theta).$$

Exponential continuity:

$\{u_\theta\}_\theta$  is exponentially continuous w.r.t.  $\theta$  if the following holds.

For all  $\theta \in \Theta$  it holds for  $\nu$ -a.e.  $y \in Y$  the following limit exists

$$\lim_{t \rightarrow \infty} \frac{1}{t} \log \int_X \exp(-l_\theta^t(x, y)) du_\theta(x)$$

$$=: -V(\theta)$$

and if  $(\theta_t)_{t \in T}$  is a family of parameters s.t.  $\theta_t \rightarrow \theta$  in  $\Theta$  then

$$\lim_{t \rightarrow \infty} \log \int_X \exp(-l_{\theta_t}^t(x, y)) du_{\theta_t}(x) = -V(\theta)$$

Prop.  $\{\mu_\theta\}_{\theta \in \Theta}$  is an exponentially continuous family w.r.t.  $\ell$  and  $\pi$  is a Borel measure on  $\Theta$ . For  $v$ -almost every  $y \in Y$

$$\lim_{t \rightarrow \infty} -\frac{1}{t} \log Z_t^T(y) = \inf_{\theta \in \text{Supp}(\pi)} V(\theta)$$